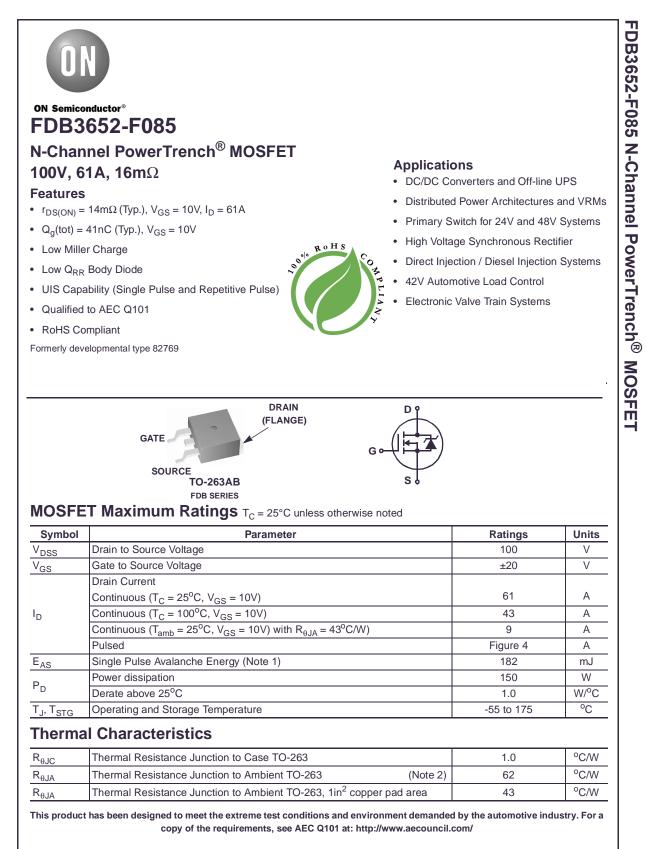
**ON Semiconductor** 

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# Onsemi

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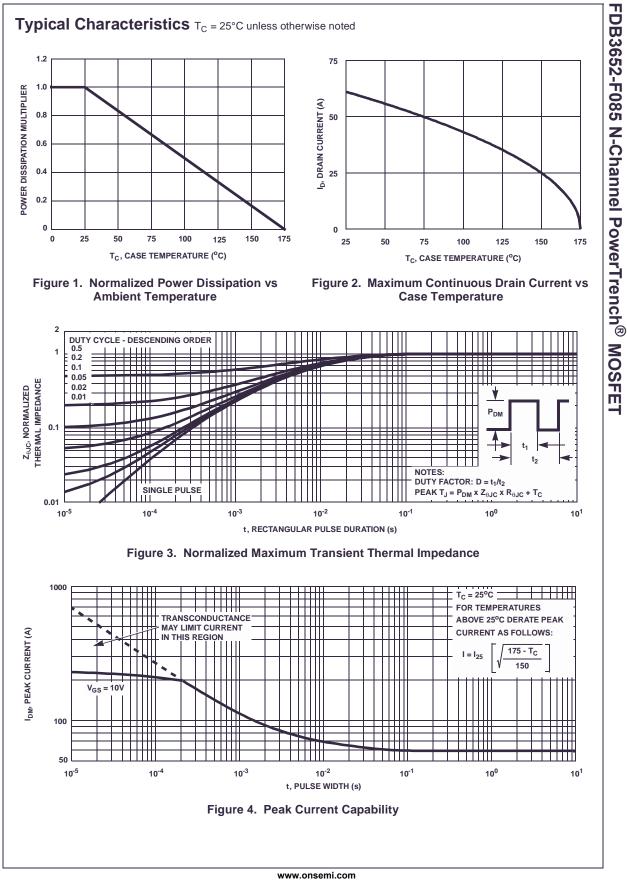


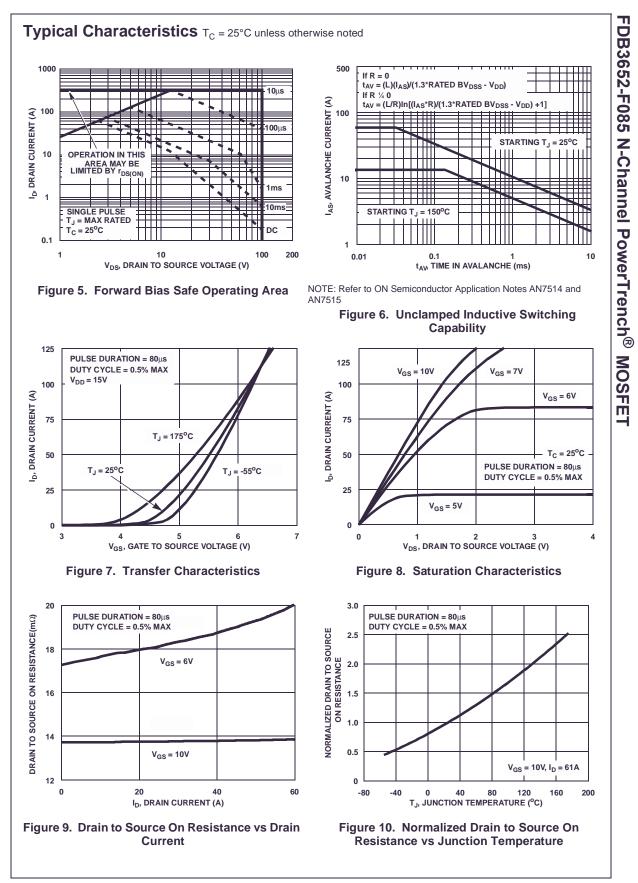
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Publication Order Number: FDB3652-F085/D

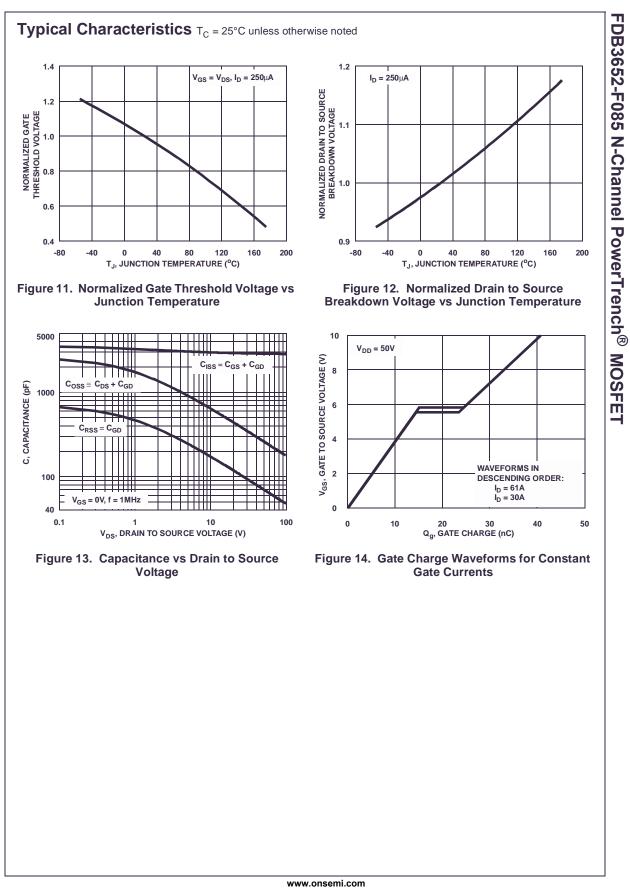
3652	Device	Package	Reel Size	Tape Width		Quantity	
FDB3652 FDB3652-F085		TO-263AB 330mm		24mm		800 units	
al Chara	acteristics T <sub>C</sub> = 25°C	cunless otherwise	e noted				
Symbol Parameter		Test Conditions		Min	Тур	Max	Units
cteristics	6						
Drain to Source Breakdown Voltage		I <sub>D</sub> = 250μA, V	$I_{D} = 250 \mu A, V_{GS} = 0 V$		-	-	V
Zero Gate Voltage Drain Current		V <sub>DS</sub> = 80V		-	-	1	μA
			T <sub>C</sub> = 150°C	-	-	250	
Gate to Source Leakage Current		$V_{GS} = \pm 20V$		-	-	±100	nA
cteristics	5						
Gate to Source Threshold Voltage		$V_{GS} = V_{DS}$ , I	$V_{GS} = V_{DS}, I_{D} = 250 \mu A$		-	4	V
1			$I_{D} = 61A, V_{GS} = 10V$		0.014	0.016	
Drain to S					0.018	0.026	
DS(ON) Drain to Source On Resistance		$I_{\rm D} = 61  \text{A},  \text{V}_{\rm GS}$	$I_{\rm D} = 61$ A, $V_{\rm GS} = 10$ V,		0.035	0.043	Ω
		1j=1/5 C					
Characte	ristics						
Input Capa	acitance		e) (	-	2880	-	pF
Output Ca	pacitance				390	-	pF
Reverse T	ransfer Capacitance			-	100	-	pF
Total Gate	Charge at 10V				41	53	nC
Threshold	Gate Charge	$V_{GS} = 0V$ to 2	$V_{DD} = 50V$	-	5	6.5	nC
Gate to Source Gate Charge			I <sub>D</sub> = 61A		15	-	nC
Gate Char	ge Threshold to Plateau		$I_g = 1.0 \text{mA}$	-	10	-	nC
Gate to Dr	ain "Miller" Charge			-	10	-	nC
n Charact	parietice $(1/ - 10)()$						
						146	ns
					12	140	ns
Rise Time Turn-Off Delay Time			-			_	ns
				_		_	ns
						_	ns
-				-	-	107	ns
	e Characteristics			1	1		
		I <sub>SD</sub> = 61A		-	-	1.25	V
I Source to	Drain Diode Voltage	$I_{SD} = 30A$		-	-	1.0	V
00010010			<sub>SD</sub> /dt = 100A/µs	-	-	62	ns
Reverse R	ecovery Time		<sub>SD</sub> /dt = 100A/µs	1	1	45	nC
	Zero Gate Gate to So Gate to So Gate to So Drain to So Drain to So Characte Input Capa Output Ca Reverse Tr Total Gate Threshold Gate to So Gate Char Gate to Dr Gate to Dr <b>Charact</b> Turn-On T Turn-On D Rise Time Turn-Off D Fall Time	Zero Gate Voltage Drain Current Gate to Source Leakage Current <b>cteristics</b> Gate to Source Threshold Voltage Drain to Source On Resistance <b>Characteristics</b> Input Capacitance Output Capacitance Reverse Transfer Capacitance Total Gate Charge at 10V Threshold Gate Charge Gate to Source Gate Charge Gate to Source Gate Charge Gate Charge Threshold to Plateau Gate to Drain "Miller" Charge <b>Characteristics</b> (V <sub>GS</sub> = 10V) Turn-On Time Turn-On Delay Time Rise Time Turn-Off Delay Time	Zero Gate Voltage Drain Current $V_{DS} = 80V$ $V_{GS} = 0V$ Gate to Source Leakage Current $V_{GS} = 420V$ cteristicsGate to Source Threshold Voltage $V_{GS} = V_{DS}$ , $I_D$ Drain to Source On Resistance $I_D = 61A$ , $V_{GS}$ Input Capacitance $I_D = 61A$ , $V_{GS}$ Output Capacitance $V_{DS} = 25V$ , $V_{f}$ Total Gate Charge at 10V $V_{GS} = 0V$ to 1Threshold Gate Charge $V_{GS} = 0V$ to 2Gate to Source Gate Charge $V_{GS} = 0V$ to 2Gate to Drain "Miller" Charge $V_{GS} = 10V$ )Turn-On TimeTurn-On TimeTurn-On Time $V_{GS} = 10V$ )Turn-Off Delay Time $V_{GS} = 10V$ , $R_{S} = 10V$	Zero Gate Voltage Drain Current $V_{DS} = 80V$ $V_{GS} = 0V$ $T_C = 150^{\circ}C$ Gate to Source Leakage Current $V_{GS} = V_{DS}$ , $I_D = 250\mu$ AGate to Source Threshold Voltage $V_{GS} = V_{DS}$ , $I_D = 250\mu$ ADrain to Source On Resistance $I_D = 61A$ , $V_{GS} = 10V$ Drain to Source On Resistance $I_D = 61A$ , $V_{GS} = 10V$ Input Capacitance $V_{DS} = 25V$ , $V_{GS} = 0V$ , $T_J = 175^{\circ}C$ Characteristics $V_{DS} = 25V$ , $V_{GS} = 0V$ , $f = 1MHz$ Input Capacitance $V_{GS} = 0V$ to $10V$ Output Capacitance $V_{GS} = 0V$ to $10V$ Threshold Gate Charge at $10V$ $V_{GS} = 0V$ to $2V$ Gate to Source Gate Charge $V_{GS} = 0V$ to $2V$ Gate to Drain "Miller" Charge $I_D = 61A$ Gate to Drain "Miller" Charge $I_D = 50V$ , $I_D = 61A$ Gate to Drain "Miller" Charge $V_{DD} = 50V$ , $I_D = 61A$ Turn-On Time $V_{CS} = 10V$ , $R_{GS} = 6.8\Omega$ Fall Time $V_{GS} = 10V$ , $R_{GS} = 6.8\Omega$	$\begin{tabular}{ c c c c c } \hline V_{GS} = 80V & \hline T_C = 150^\circ C & - \\ \hline Gate to Source Leakage Current & V_{GS} = 0V & \hline T_C = 150^\circ C & - \\ \hline Gate to Source Leakage Current & V_{GS} = \pm 20V & - \\ \hline \hline Gate to Source Threshold Voltage & V_{GS} = V_{DS}, I_D = 250\mu A & 2 \\ \hline I_D = 61A, V_{GS} = 10V & - \\ \hline I_D = 30A, V_{GS} = 6V & - \\ \hline I_D = 61A, V_{GS} = 10V, & - \\ \hline I_D = 61A, V_{GS} = 10V, & - \\ \hline I_D = 61A, V_{GS} = 10V, & - \\ \hline I_D = 61A, V_{GS} = 0V, & - \\ \hline I_D = 61A, V_{GS} = 0V, & - \\ \hline I_D = 61A, V_{GS} = 0V, & - \\ \hline I_D = 61A, V_{GS} = 0V, & - \\ \hline Characteristics & \\ \hline Input Capacitance & V_{DS} = 25V, V_{GS} = 0V, & - \\ \hline Characteristics & \\ \hline Input Capacitance & V_{DS} = 25V, V_{GS} = 0V, & - \\ \hline Characteristics & V_{GS} = 0V to 10V & V_{GS} = 0V to 10V \\ \hline Threshold Gate Charge & V_{GS} = 0V to 2V & V_{DD} = 50V & - \\ \hline Gate to Source Gate Charge & V_{GS} = 0V to 2V & V_{DD} = 50V & - \\ \hline Gate to Drain "Miller" Charge & & I_D = 61A & \\ I_g = 1.0mA & - \\ \hline Characteristics (V_{GS} = 10V) & \\ \hline Turn-On Time & \\ \hline Turn-On Time & \\ \hline Turn-On Delay Time & \\ \hline Rise Time & V_{DD} = 50V, I_D = 61A & \\ \hline V_{DD} = 50V, I_D = 61A & - \\ \hline V_{DD} = 50V, I_D = 61A & - \\ \hline V_{DD} = 50V, I_D = 61A & - \\ \hline V_{DD} = 10V, R_{GS} = 6.8\Omega & - \\ \hline Fall Time & & V_{DD} = 50V, I_D = 61A & - \\ \hline V_{DD} $	$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$	$\begin{tabular}{ c c c c c c c c c c c c c c c c c c c$

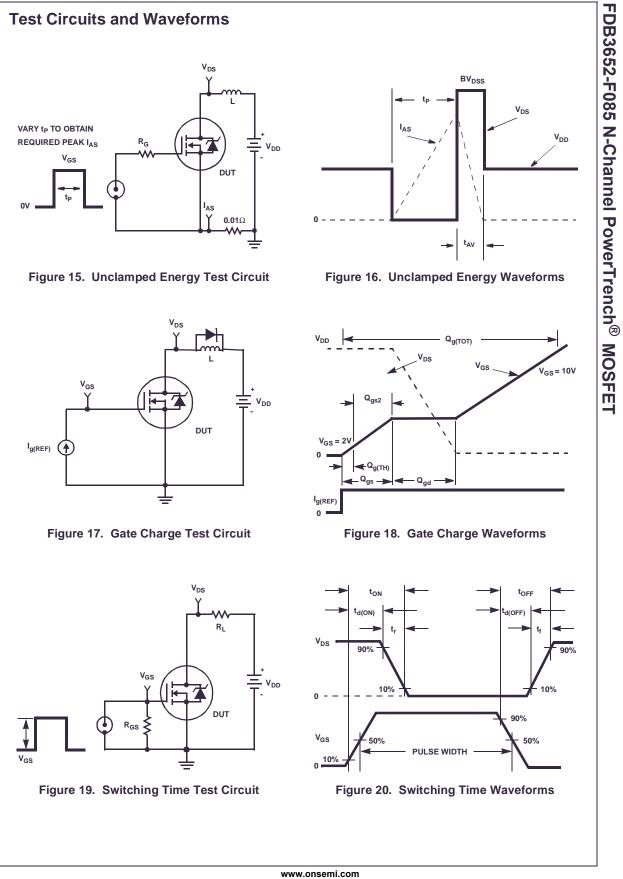
FDB3652-F085 N-Channel PowerTrench® MOSFET





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## Thermal Resistance vs. Mounting Pad Area

The maximum rated junction temperature,  $T_{JM}$ , and the thermal resistance of the heat dissipating path determines the maximum allowable device power dissipation,  $P_{DM}$ , in an application. Therefore the application's ambient temperature,  $T_A$  (°C), and thermal resistance  $R_{\theta JA}$  (°C/W) must be reviewed to ensure that  $T_{JM}$  is never exceeded. Equation 1 mathematically represents the relationship and serves as the basis for establishing the rating of the part.

$$P_{DM} = \frac{(T_{JM} - T_A)}{R_{\theta JA}}$$
(EQ. 1)

In using surface mount devices such as the TO-263 package, the environment in which it is applied will have a significant influence on the part's current and maximum power dissipation ratings. Precise determination of  $\mathsf{P}_{\mathsf{DM}}$  is complex and influenced by many factors:

- Mounting pad area onto which the device is attached and whether there is copper on one side or both sides of the board.
- 2. The number of copper layers and the thickness of the board.
- 3. The use of external heat sinks.
- 4. The use of thermal vias.
- 5. Air flow and board orientation.
- 6. For non steady state applications, the pulse width, the duty cycle and the transient thermal response of the part, the board and the environment they are in.

ON Semiconductor provides thermal information to assist the designer's preliminary application evaluation. Figure 21 defines the R0JA for the device as a function of the top copper (component side) area. This is for a horizontally positioned FR-4 board with 1oz copper after 1000 seconds of steady state power with no air flow. This graph provides the necessary information for calculation of the steady state junction temperature or power dissipation. Pulse applications can be evaluated using the ON Semiconductor device Spice thermal model or manually utilizing the normalized maximum transient thermal impedance curve.

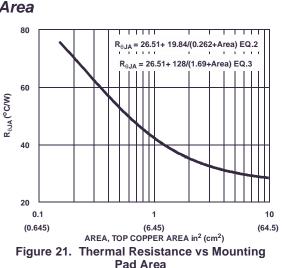
Thermal resistances corresponding to other copper areas can be obtained from Figure 21 or by calculation using Equation 2 or 3. Equation 2 is used for copper area defined in inches square and equation 3 is for area in centimeter square. The area, in square inches or square centimeters is the top copper area including the gate and source pads.

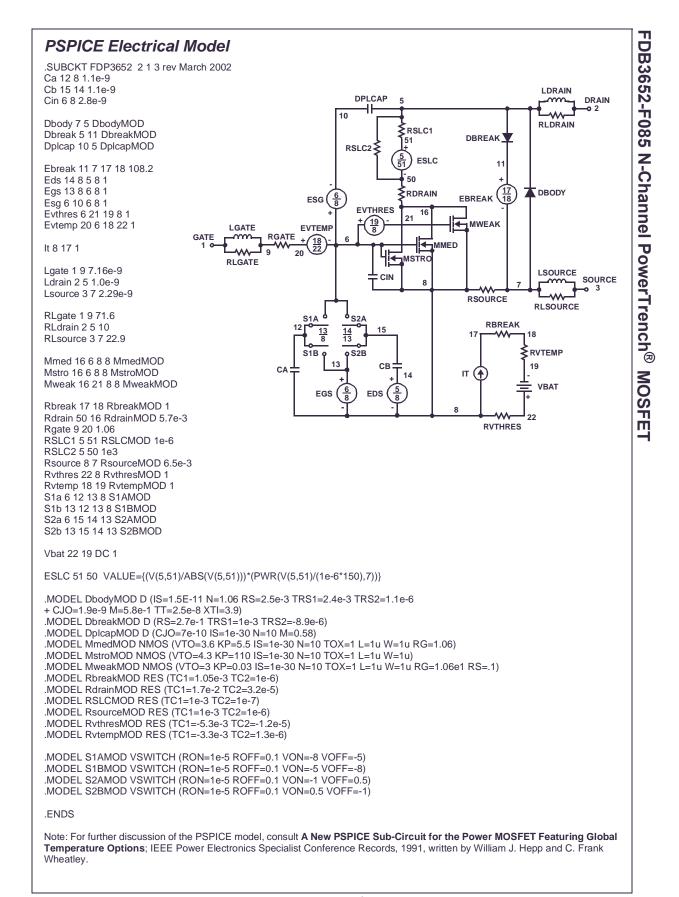
$$R_{\theta JA} = 26.51 + \frac{19.84}{(0.262 + Area)}$$
(EQ. 2)

Area in Iches Squared

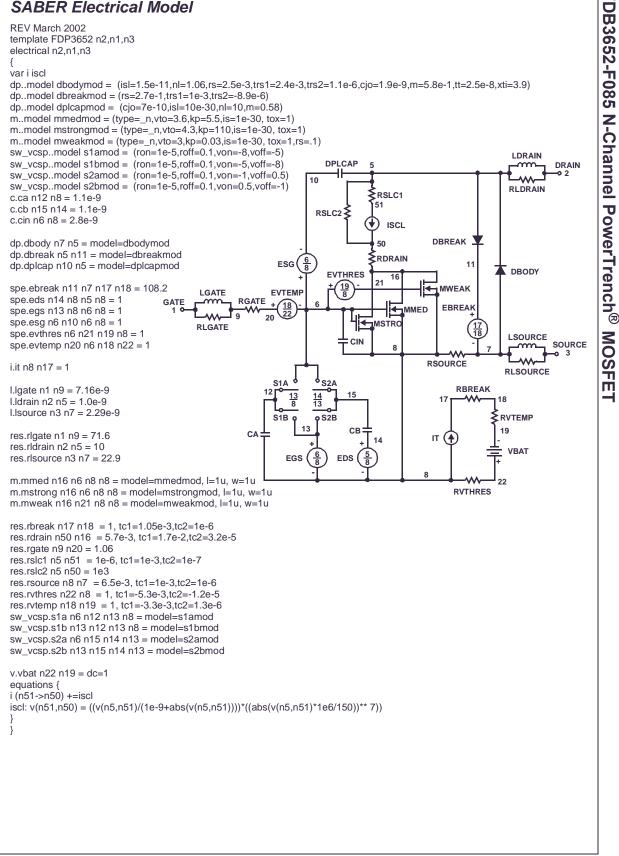
$$R_{\Theta JA} = 26.51 + \frac{128}{(1.69 + Area)}$$
 (EQ. 3)

Area in Centimeter Squared



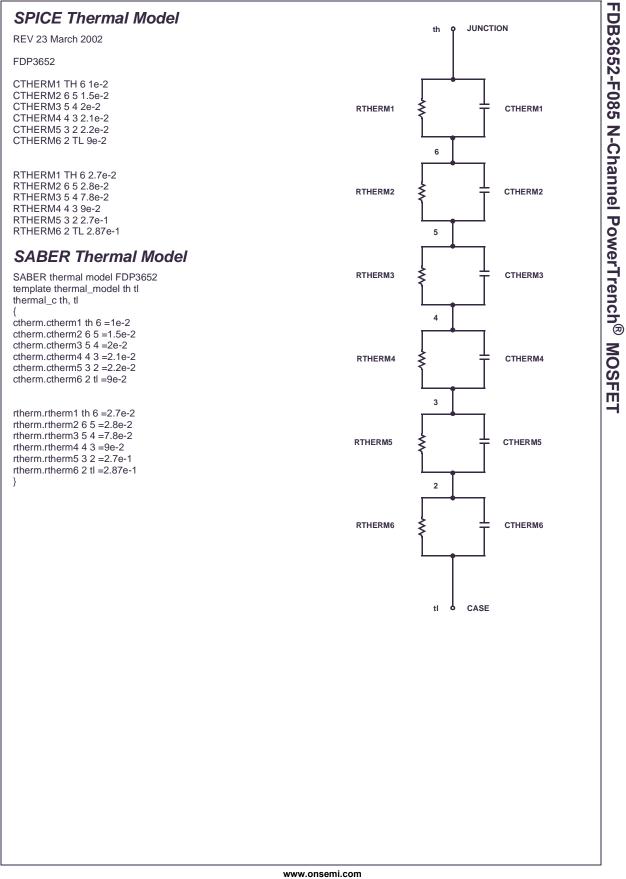


# SABER Electrical Model



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